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- Choice of Eight Latches or Eight D-Type Flip-Flops in a Single Package
- 3-State Bus-Driving Outputs
- Full Parallel Access for Loading
- Buffered Control Inputs
- Clock-Enable Input Has Hysteresis to Improve Noise Rejection ('S373 and 'S374)
- P-N-P Inputs Reduce DC Loading on Data Lines ('S373 and 'S374)

description

These 8-bit registers feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. The high-impedance 3-state and increased high-logic-level drive provide these registers with the capability of being connected directly to and driving the bus lines in a bus-organized system without need for interface or pullup components. These devices are particularly attractive for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

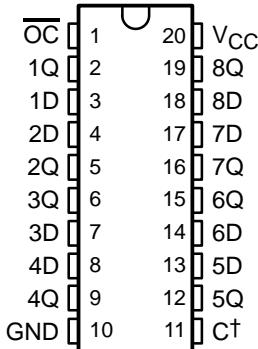
The eight latches of the 'LS373 and 'S373 are transparent D-type latches, meaning that while the enable (C or CLK) input is high, the Q outputs follow the data (D) inputs. When C or CLK is taken low, the output is latched at the level of the data that was set up.

The eight flip-flops of the 'LS374 and 'S374 are edge-triggered D-type flip-flops. On the positive transition of the clock, the Q outputs are set to the logic states that were set up at the D inputs.

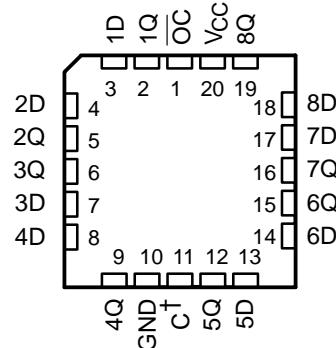
Schmitt-trigger buffered inputs at the enable/clock lines of the 'S373 and 'S374 devices simplify system design as ac and dc noise rejection is improved by typically 400 mV due to the input hysteresis. A buffered output-control (\overline{OC}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly.

\overline{OC} does not affect the internal operation of the latches or flip-flops. That is, the old data can be retained or new data can be entered, even while the outputs are off.

SN54LS373, SN54LS374, SN54S373,
SN54S374 . . . J OR W PACKAGE
SN74LS373, SN74S374 . . . DW, N, OR NS PACKAGE
SN74LS374 . . . DB, DW, N, OR NS PACKAGE
SN74S373 . . . DW OR N PACKAGE
(TOP VIEW)



SN54LS373, SN54LS374, SN54S373,
SN54S374 . . . FK PACKAGE
(TOP VIEW)



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SN54LS373, SN54LS374, SN54S373, SN54S374,

SN74LS373, SN74LS374, SN74S373, SN74S374

OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS

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ORDERING INFORMATION

T _A	PACKAGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	PDIP – N	Tube	SN74LS373N
		Tube	SN74LS374N
		Tube	SN74S373N
		Tube	SN74S374N
	SOIC – DW	Tube	SN74LS373DW
		Tape and reel	SN74LS373DWR
		Tube	SN74LS374DW
		Tape and reel	SN74LS374DWR
	SOP – NS	Tube	SN74S373DW
		Tape and reel	SN74S373DWR
		Tube	SN74S374DW
		Tape and reel	SN74S374DWR
	SSOP – DB	Tape and reel	SN74LS373NSR
		Tape and reel	74LS373
		Tape and reel	74LS374
-55°C to 125°C	CDIP – J	Tube	SN54LS373J
		Tube	SNJ54LS373J
		Tube	SN54LS374J
		Tube	SNJ54LS374J
		Tube	SN54S373J
		Tube	SNJ54S373J
		Tube	SN54S374J
		Tube	SNJ54S374J
	CFP – W	Tube	SNJ54LS373W
		Tube	SNJ54LS374W
		Tube	SNJ54S374W
	LCCC – FK	Tube	SNJ54LS373FK
		Tube	SNJ54LS374FK
		Tube	SNJ54S373FK
		Tube	SNJ54S374FK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Function Tables

'LS373, 'S373
(each latch)

INPUTS			OUTPUT
\overline{OC}	C	D	Q
L	H	H	H
L	H	L	L
L	L	X	Q_0
H	X	X	Z

'LS374, 'S374
(each latch)

INPUTS			OUTPUT
\overline{OC}	CLK	D	Q
L	\uparrow	H	H
L	\uparrow	L	L
L	L	X	Q_0
H	X	X	Z

SN54LS373, SN54LS374, SN54S373, SN54S374,

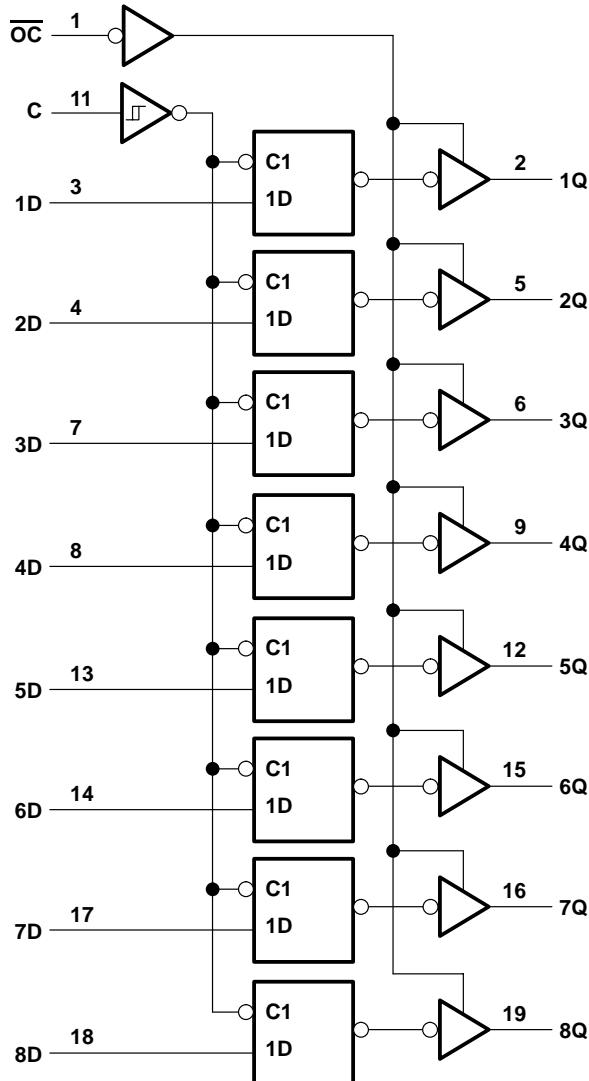
SN74LS373, SN74LS374, SN74S373, SN74S374

OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS

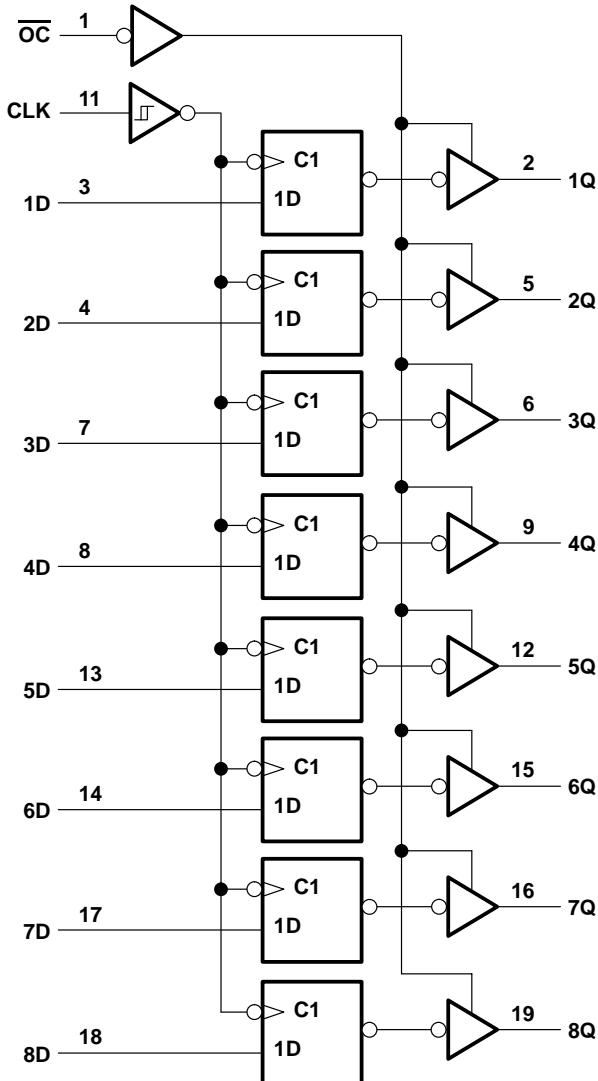
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logic diagrams (positive logic)

'LS373, 'S373
Transparent Latches



'LS374, 'S374
Positive-Edge-Triggered Flip-Flops



□ for 'S373 Only

□ for 'S374 Only

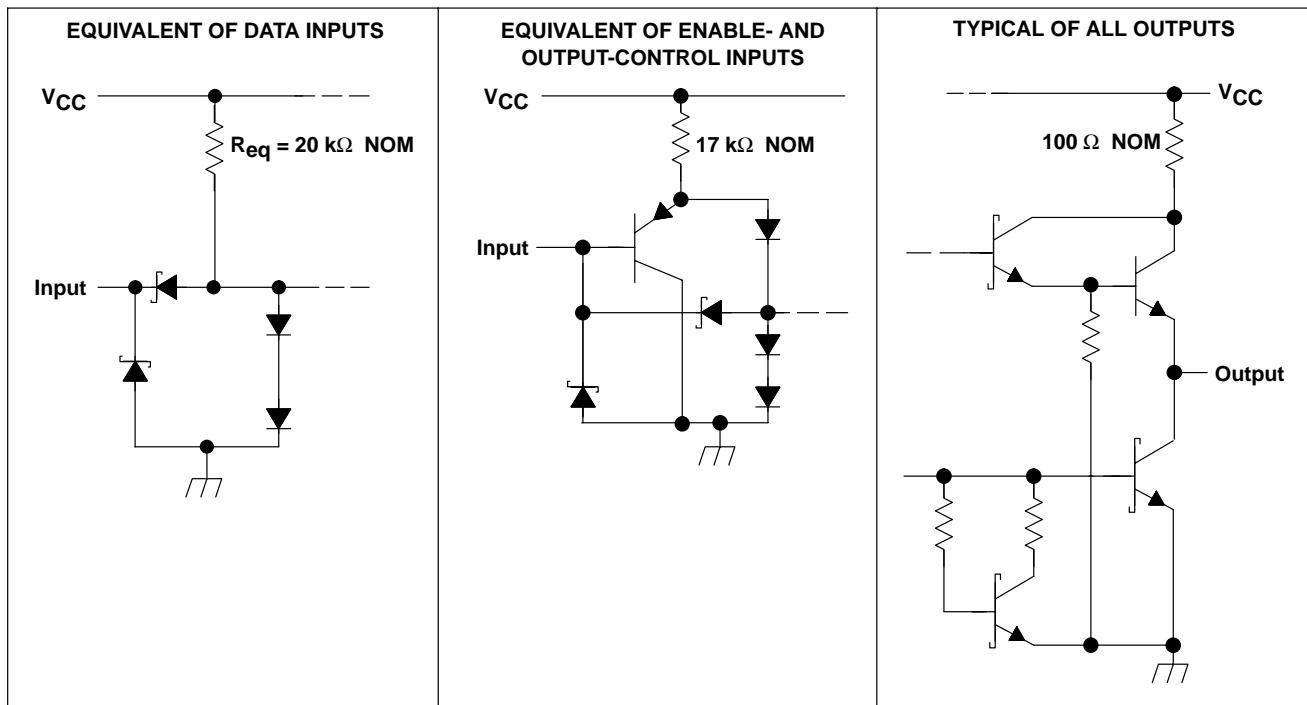
Pin numbers shown are for DB, DW, J, N, NS, and W packages.

**SN54LS373, SN54LS374, SN54S373, SN54S374,
SN74LS373, SN74LS374, SN74S373, SN74S374**
OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS

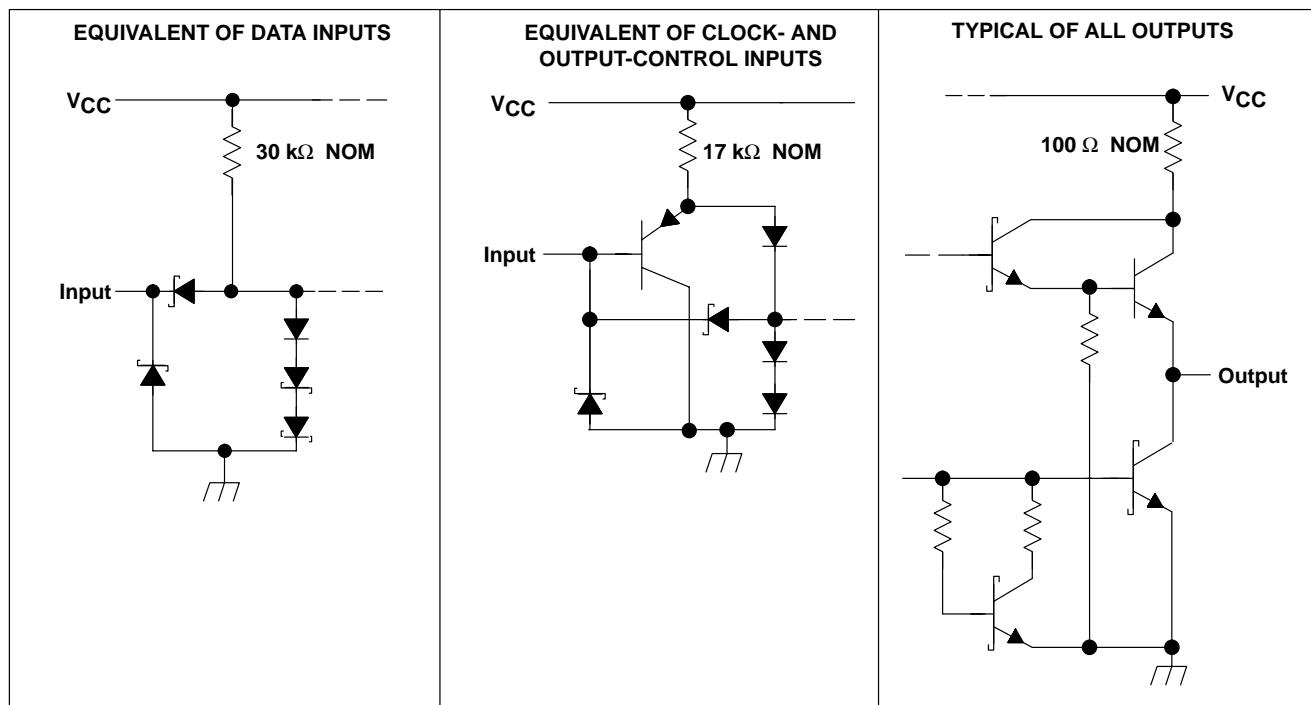
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schematic of inputs and outputs

'LS373



'LS374



**SN54LS373, SN54LS374, SN54S373, SN54S374,
SN74LS373, SN74LS374, SN74S373, SN74S374**

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†
(‘LS devices)

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Voltage values are with respect to network ground terminal.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

			SN54LS'			SN74LS'			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5	4.75	5	5.25	V
V _{OH}	High-level output voltage				5.5			5.5	V
I _{OH}	High-level output current				-1			-2.6	mA
I _{OL}	Low-level output current				12			24	mA
t _w	Pulse duration	CLK high			15			15	ns
		CLK low			15			15	
t _{su}	Data setup time	'LS373			5↓			5↓	ns
		'LS374			20↑			20↑	
t _h	Data hold time	'LS373			20↓			20↓	ns
		'LS374‡			5↑			0↑	
T _A	Operating free-air temperature		-55		125	0		70	°C

‡ The t_h specification applies only for data frequency below 10 MHz. Designs above 10 MHz should use a minimum of 5 ns (commercial only).

**SN54LS373, SN54LS374, SN54S373, SN54S374,
SN74LS373, SN74LS374, SN74S373, SN74S374**
OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS
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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54LS'			SN74LS'			UNIT
		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	
V_{IH}	High-level input voltage			2			2	V
V_{IL}	Low-level input voltage				0.7		0.8	V
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = -18 \text{ mA}$			-1.5		-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IL} = V_{IL \text{ max}}$, $I_{OH} = \text{MAX}$	2.4	3.4	2.4	3.1		V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IL} = V_{IL \text{ max}}$	$I_{OL} = 12 \text{ mA}$	0.25	0.4	0.25	0.4	V
			$I_{OL} = 24 \text{ mA}$			0.35	0.5	
I_{OZH}	Off-state output current, high-level voltage applied	$V_{CC} = \text{MAX}$, $V_O = 2.7 \text{ V}$			20		20	μA
I_{OZL}	Off-state output current, low-level voltage applied	$V_{CC} = \text{MAX}$, $V_O = 0.4 \text{ V}$			-20		-20	μA
I_I	Input current at maximum input voltage	$V_{CC} = \text{MAX}$, $V_I = 7 \text{ V}$			0.1		0.1	mA
I_{IH}	High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$			20		20	μA
I_{IL}	Low-level input current	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$			-0.4		-0.4	mA
I_{OS}	Short-circuit output current [§]	$V_{CC} = \text{MAX}$		-30	-130	-30	-130	mA
I_{CC}	Supply current	$V_{CC} = \text{MAX}$, Output control at 4.5 V	'LS373	24	40	24	40	mA
			'LS374	27	40	27	40	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

[§] Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS373			'LS374			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
f_{max}			$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, See Note 3				35	50		MHz
t_{PLH}	Data	Any Q	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, See Note 3	12	18					ns
t_{PHL}				12	18					
t_{PLH}	C or CLK	Any Q	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, See Note 3	20	30		15	28		ns
t_{PHL}				18	30		19	28		
t_{PZH}	\overline{OC}	Any Q	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, See Note 3	15	28		20	26		ns
t_{PZL}				25	36		21	28		
t_{PHZ}	\overline{OC}	Any Q	$R_L = 667 \Omega$, $C_L = 5 \text{ pF}$	15	25		15	28		ns
t_{PLZ}				12	20		12	20		

NOTE 3: Maximum clock frequency is tested with all outputs loaded.

f_{max} = maximum clock frequency

t_{PLH} = propagation delay time, low-to-high-level output

t_{PHL} = propagation delay time, high-to-low-level output

t_{PZH} = output enable time to high level

t_{PZL} = output enable time to low level

t_{PHZ} = output disable time from high level

t_{PLZ} = output disable time from low level

SN54LS373, SN54LS374, SN54S373, SN54S374,

SN74LS373, SN74LS374, SN74S373, SN74S374

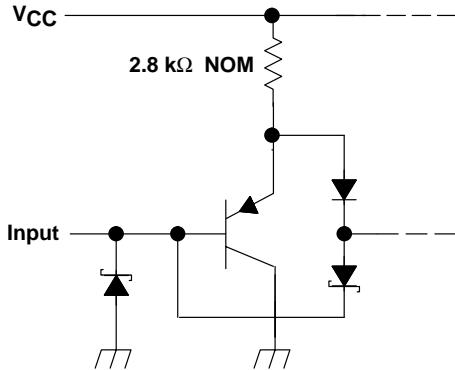
OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS

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schematic of inputs and outputs

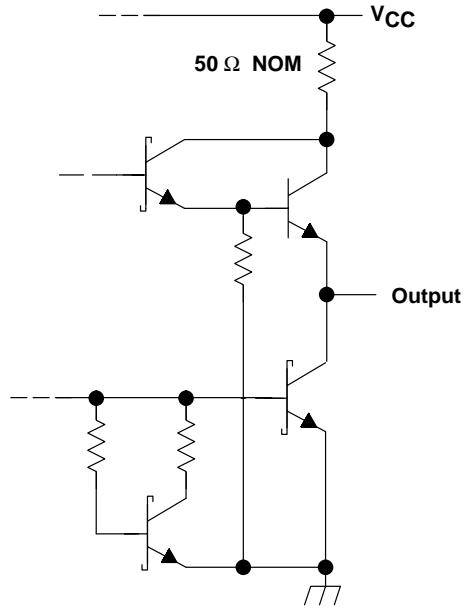
'S373 and 'S374

EQUIVALENT OF EACH INPUT



'S373 and 'S374

TYPICAL OF ALL OUTPUTS



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]
('S devices)

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Voltage values are with respect to network ground terminal.
2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

			SN54S'			SN74S'			UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX		
V _{CC}	Supply voltage			4.5	5	5.5	4.75	5	5.25	V
V _{OH}	High-level output voltage			5.5			5.5			V
I _{OH}	High-level output current			-2			-6.5			mA
t _w	Pulse duration, clock/enable	High	6			6			ns	
		Low	7.3			7.3				
t _{su}	Data setup time	'S373	0↓			0↓			ns	
		'S374	5↑			5↑				
t _h	Data hold time	'S373	10↓			10↓			ns	
		'S374	2↑			2↑				
T _A	Operating free-air temperature			-55	125		0	70	°C	

SN54LS373, SN54LS374, SN54S373, SN54S374,

SN74LS373, SN74LS374, SN74S373, SN74S374

OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (SN54S373, SN54S374, SN74S373, SN74S374)

PARAMETER		TEST CONDITIONS [†]				MIN	TYP [‡]	MAX	UNIT	
V_{IH}						2			V	
V_{IL}						0.8			V	
V_{IK}		$V_{CC} = \text{MIN}$, $I_I = -18 \text{ mA}$				-1.2			V	
V_{OH}	SN54S' SN74S'	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OH} = \text{MAX}$				2.4	3.4		V	
						2.4	3.1			
V_{OL}		$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 20 \text{ mA}$				0.5			V	
I_{OZH}		$V_{CC} = \text{MAX}$, $V_{IH} = 2 \text{ V}$, $V_O = 2.4 \text{ V}$				50			μA	
I_{OZL}		$V_{CC} = \text{MAX}$, $V_{IH} = 2 \text{ V}$, $V_O = 0.5 \text{ V}$				-50			μA	
I_I		$V_{CC} = \text{MAX}$, $V_I = 5.5 \text{ V}$				1			mA	
I_{IH}		$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$				50			μA	
I_{IL}		$V_{CC} = \text{MAX}$, $V_I = 0.5 \text{ V}$				-250			μA	
$I_{OS}^§$		$V_{CC} = \text{MAX}$				-40	-100		mA	
I_{CC}	$V_{CC} = \text{MAX}$	'S373	Outputs high			160			mA	
			Outputs low			160				
			Outputs disabled			190				
		'S374	Outputs high			110				
			Outputs low			140				
			Outputs disabled			160				
			CLK and \overline{OC} at 4 V, D inputs at 0 V			180				

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

[§] Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'S373			'S374			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
f_{max}			$R_L = 280 \Omega$, $C_L = 15 \text{ pF}$, See Note 3				75	100		MHz
t_{PLH}	Data	Any Q	$R_L = 280 \Omega$, $C_L = 15 \text{ pF}$, See Note 3	7	12					ns
t_{PHL}				7	12					
t_{PLH}	C or CLK	Any Q	$R_L = 280 \Omega$, $C_L = 15 \text{ pF}$, See Note 3	7	14		8	15		ns
t_{PHL}				12	18		11	17		
t_{PZH}	\overline{OC}	Any Q	$R_L = 280 \Omega$, $C_L = 15 \text{ pF}$, See Note 3	8	15		8	15		ns
t_{PZL}				11	18		11	18		
t_{PHZ}	\overline{OC}	Any Q	$R_L = 280 \Omega$, $C_L = 5 \text{ pF}$	6	9		5	9		ns
t_{PLZ}				8	12		7	12		

NOTE 3. Maximum clock frequency is tested with all outputs loaded.

f_{max} = maximum clock frequency

t_{PLH} = propagation delay time, low-to-high-level output

t_{PHL} = propagation delay time, high-to-low-level output

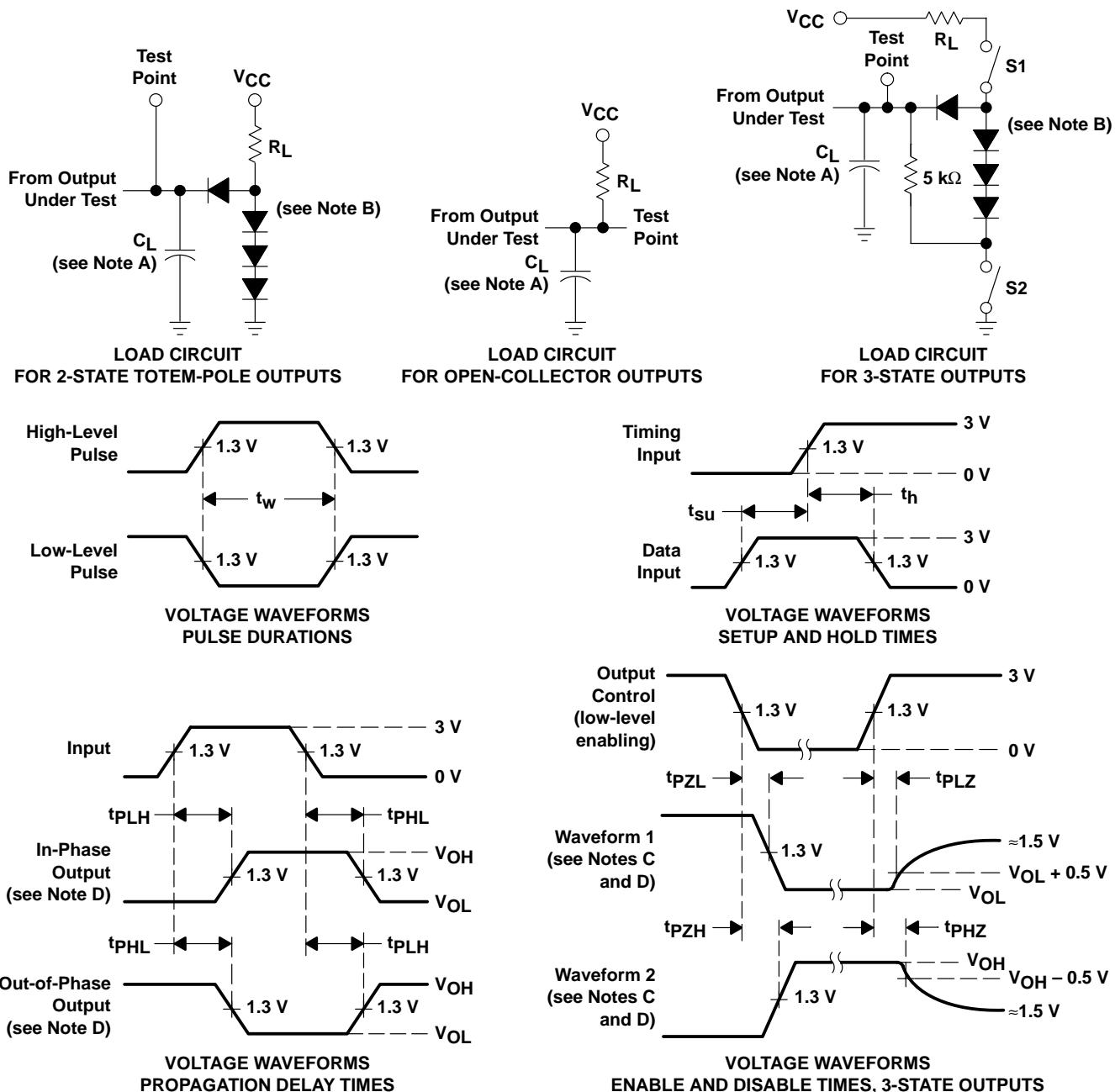
t_{PZH} = output enable time to high level

t_{PZL} = output enable time to low level

t_{PHZ} = output disable time from high level

t_{PLZ} = output disable time from low level

PARAMETER MEASUREMENT INFORMATION
 SERIES 54LS/74LS DEVICES



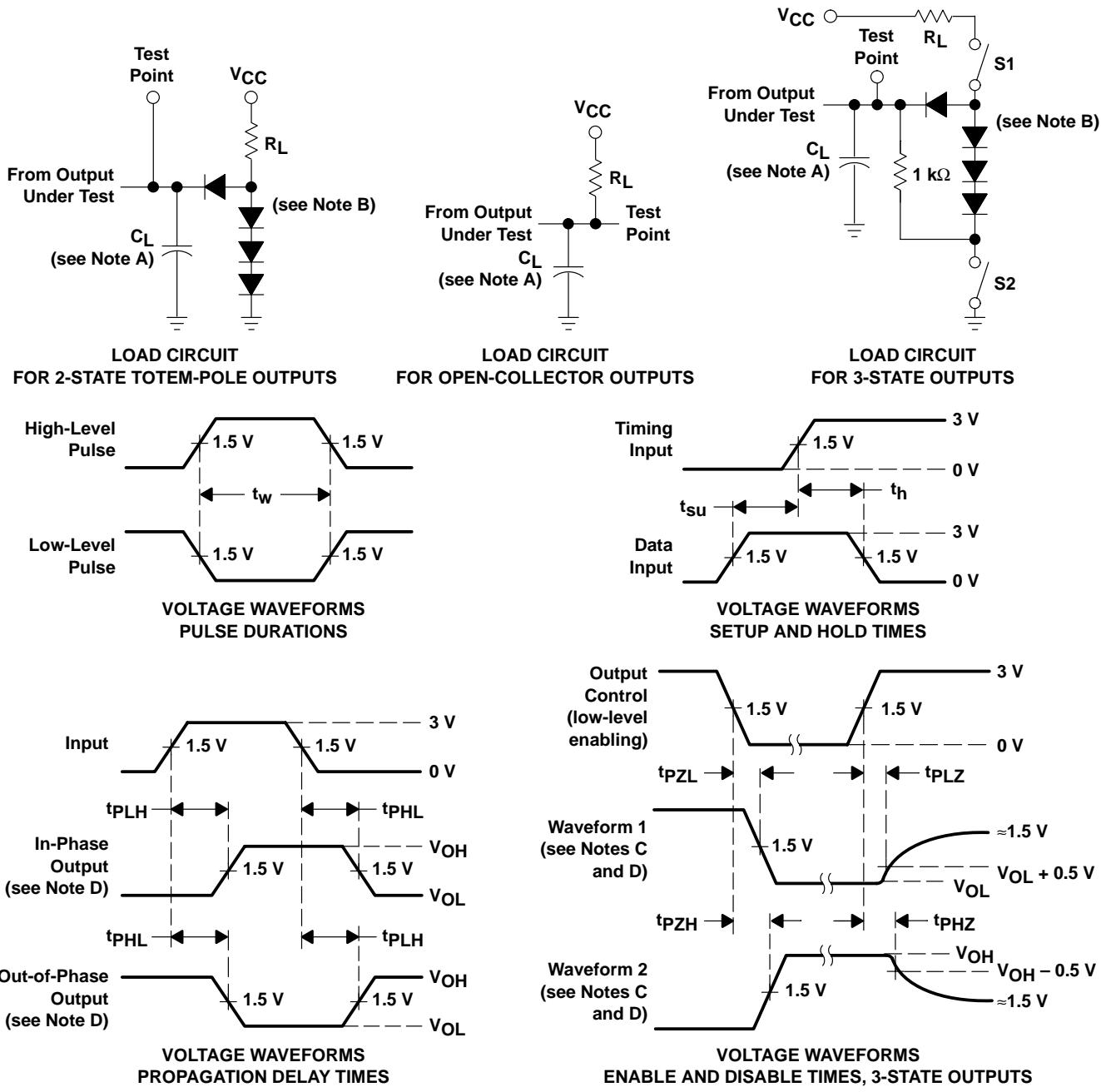
NOTES: A. C_L includes probe and jig capacitance.
 B. All diodes are 1N3064 or equivalent.
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
 Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 D. S1 and S2 are closed for t_{PLH} , t_{PHL} , t_{PHZ} , and t_{PLZ} ; S1 is open and S2 is closed for t_{PZH} ; S1 is closed and S2 is open for t_{PZL} .
 E. Phase relationships between inputs and outputs have been chosen arbitrarily for these examples.
 F. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O \approx 50 \Omega$, $t_r \leq 1.5 \text{ ns}$, $t_f \leq 2.6 \text{ ns}$.
 G. The outputs are measured one at a time with one input transition per measurement.
 H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuits and Voltage Waveforms

**SN54LS373, SN54LS374, SN54S373, SN54S374,
SN74LS373, SN74LS374, SN74S373, SN74S374
OCTAL D-TYPE TRANSPARENT LATCHES AND EDGE-TRIGGERED FLIP-FLOPS**

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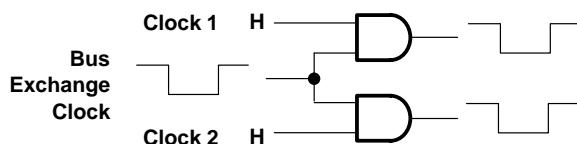
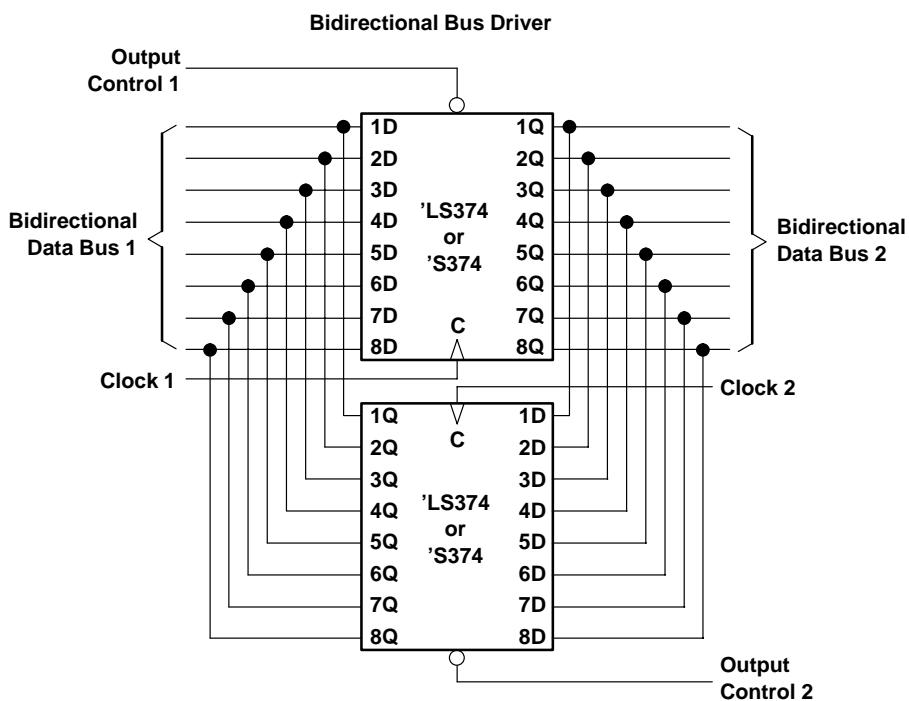
**PARAMETER MEASUREMENT INFORMATION
SERIES 54S/74S DEVICES**



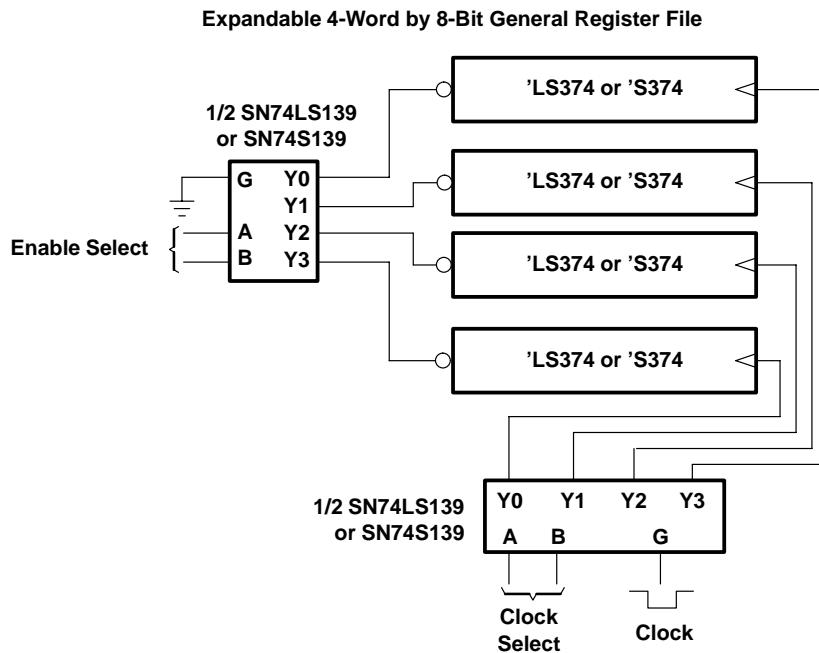
NOTES: A. C_L includes probe and jig capacitance.
 B. All diodes are 1N3064 or equivalent.
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 D. S1 and S2 are closed for t_{PLH} , t_{PHL} , t_{PHZ} , and t_{PLZ} ; S1 is open and S2 is closed for t_{PZH} ; S1 is closed and S2 is open for t_{PZL} .
 E. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, $Z_O \approx 50 \Omega$; t_r and $t_f \leq 7$ ns for Series 54/74 devices and t_r and $t_f \leq 2.5$ ns for Series 54S/74S devices.
 F. The outputs are measured one at a time with one input transition per measurement.
 G. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuits and Voltage Waveforms

TYPICAL APPLICATION DATA



Expandable 4-Word by 8-Bit General Register File



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